

Notice of References Cited	Application/Control No. 10/566,993		Applicant(s)/Patent Under Reexamination AREDDU ET AL.	
	Examiner FAN NG		Art Unit 4145	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0042398	03-2004	Peleg et al.	370/230
*	B	US-7,356,584	04-2008	Yip, John	709/224
*	C	US-6,873,600	03-2005	Duffield et al.	370/252
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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